

Title (en)

METHOD FOR EXAMINING OBJECT PROPERTIES OF AN OBJECT IN A SUBSTRATE

Title (de)

VERFAHREN ZUM ÜBERPRÜFEN VON OBJEKTEIGENSCHAFTEN EINES OBJEKTES IN EINEM UNTERGRUND

Title (fr)

PROCÉDÉ POUR CONTRÔLER DES PROPRIÉTÉS D'UN OBJET SITUÉ DANS UN SOUS-SOL

Publication

**EP 3237841 A1 20171101 (DE)**

Application

**EP 15813875 A 20151222**

Priority

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Abstract (en)

[origin: WO2016102564A1] The invention relates to a method for examining object properties of an object (23, 25) in a substrate (18), using an arrangement (10) that comprises a detector device (11), a localisation device (12) and a control device (13), in which: - in a first step, a first object having first object properties to be examined and first target coordinates is selected, - in a second step an actual position of the detector device (11) is determined using the localisation device (12), - in a third step an actual detection field is determined from the actual position of the detector device (11), by means of the control device (13) and - in a fourth step, the first target coordinates are compared with the actual detection field of the detector device (11), by said control device (13).

IPC 8 full level

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**G01C 15/006** (2013.01 - US); **G01V 3/15** (2013.01 - CN EP US)

Citation (examination)

- JP 2001289638 A 20011019 - SUMITOMO DENSETSU CORP
- US 2010125816 A1 20100520 - BEZOS JEFFREY P [US]
- EP 2306151 A1 20110406 - FRANCE TELECOM [FR]
- See also references of WO 2016102564A1

Designated contracting state (EPC)

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Designated extension state (EPC)

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DOCDB simple family (application)

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